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### MITSUBISHI SEMICONDUCTOR <GaAs FET>

# MGFS45B2527B

2.5 - 2.7GHz BAND 30W INTERNALLY MATCHED GaAs FET

#### **DESCRIPTION**

The MGFS45B2527B is an internally impedance-matched GaAs power FET especially designed for use in 2.5 - 2.7 GHz band amplifiers. The hermetically sealed metal-ceramic package guarantees high reliability.

### **FEATURES**

Class AB operation
Internally matched to 50(ohm) system
High output power
Po(SAT) = 30W (TYP.) @ f=2.5 - 2.7 GHz
High power gain

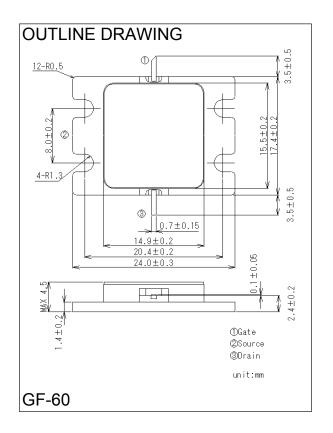
GLP = 12.5 dB (TYP.) @ f=2.5 - 2.7 GHz

Distortion

EVM = 1% (TYP.) @ f=2.5 - 2.7 GHPo=34dBm EVM = 2% (TYP.) @ f=2.5 - 2.7 GHPo=37dBm

## RECOMMENDED BIAS CONDITIONS

VDS = 12 (V) ID = 0.9 (A) RG=10 (ohm)



## ABSOLUTE MAXIMUM RATINGS (Ta=25deg.C)

Parameter	Ratings	Unit
Gate to drain voltage	-15	V
Gate to source voltage	-10	V
Maximum drain current	10	Α
Total power dissipation	78	W
Channel temperature	175	deg.C
Storage temperature	-55 / +150	deg.C
	Gate to drain voltage Gate to source voltage Maximum drain current Total power dissipation Channel temperature	Gate to drain voltage         -15           Gate to source voltage         -10           Maximum drain current         10           Total power dissipation         78           Channel temperature         175

<sup>\*1 :</sup> Tc=25deg.C

< Keep safety first in your circuit designs! > Mitsubishi Electric Corporation puts the maximum effort to

making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal

injury, fire or property damage. Remember to give due consideration to safety when making your circuit designs, with appropriate measures such as (1)placement of substitutive, auxiliary circuits, (2)use of non-flammable

## ELECTRICAL CARACTERISTICS (Ta=25deg.C)

Symbol	Parameter	Test conditions	Limits		Unit	
			Min.	Тур.	Max.	
VGS(off)	Gate to source cut-off voltage	VDS = 3V , ID = 100mA	-0.5	-	-3.0	V
Po(SAT)	Output power	VDS=12V, ID(RF off)=0.9A, f=2.5-2.7GHz	-	45	-	dBm
GLP	Linear power gain		10.0	12.5	-	dB
ID	Drain current	VDS=12V, ID(RF off)=0.9A, f=2.5-2.7GHz	-	1.2	1.5	Α
EVM *2	Error Vector Magnitude	Pout=34dBm	-	1.0	2.0	%
Rth(ch-c) *3	Thermal resistance	delta Vf method	-	1.2	1.9	deg.C/W

<sup>\*2 :</sup>WiMAX Downlink, 64QAM-3/4, Channel Bandwidth: 6MHz



<sup>\*3 :</sup> Channel-case

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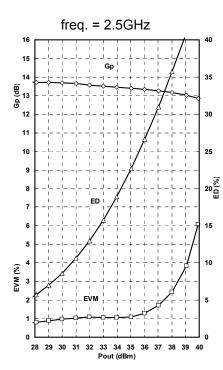
## 2.5 - 2.7GHz BAND 30W INTERNALLY MATCHED GaAs FET

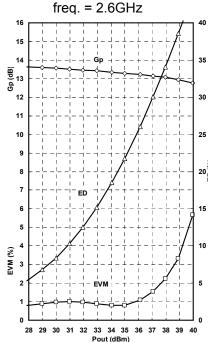
EVM(@WiMAX) vs . Pout characteristics

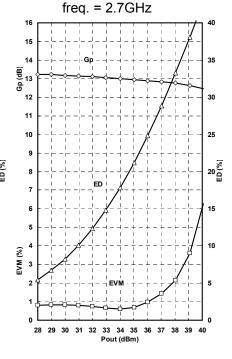
Test Condition

Vds=12V, Idq=0.9A, Ta=25deg.C

WiMAX: 64QAM-3/4,Bw=6MHz







EVM(@WiMAX) vs . Freq. characteristics

5.0 15 4.5 14 4.0 13 12 3.5 3.0 EVM(%) Gain(dB) **-**□-EVM 2.5 10 **←**Gain 2.0 9 1.5 8 1.0 7 0.5 6 0.0 5 2.3 2.4 2.5 2.6 2.7 2.8 2.9

freq(GHz)

Test Condition: Vds=12V, Idq=0.9A, Pout=34dBm, Ta=25deg.C WiMAX: 64QAM-3/4,Bw=6MHz

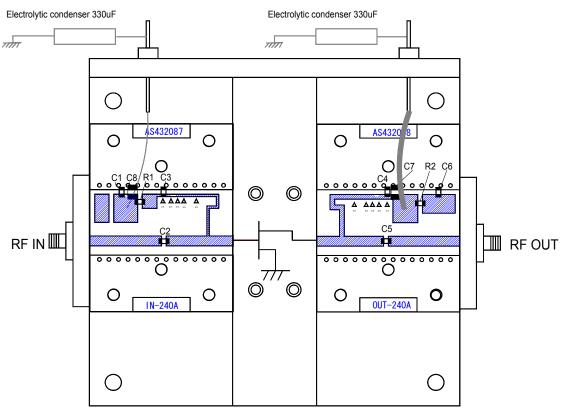
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## RF TEST FIXTURE



C1,C6=1000pF

C3,C4=20pF C2,C5=20pF

C7=470nF

C8=100nF

R1=CR10 10ohm

R2=CR10 51ohm

Board material: Teflon, t=0.8mm, Specific dielectric constant=2.6

UNIT:(mm)

Sep. 2007

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